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CAPACITORS, FIXED, CHIPS, HIGH VOLTAGE (1 TO 3KV), CERAMIC DIELECTRIC, TYPE II

BASED ON TYPES 1812 AND 1825

ESCC Detail Specification No. 3009/034

Issue 4 November 2017



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1 **GENERAL**

1.1 SCOPE

This specification details the ratings, physical and electrical characteristics, and test and inspection data for the component type variants and/or the range of components specified below. It supplements the requirements of, and shall be read in conjunction with, the ESCC Generic Specification listed under Applicable Documents.

1.2 <u>APPLICABLE DOCUMENTS</u>

The following documents form part of this specification and shall be read in conjunction with it:

(a) ESCC Generic Specification No. 3009.

1.3 TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESCC Basic Specification No. 21300 shall apply.

1.4 THE ESCC COMPONENT NUMBER AND COMPONENT TYPE VARIANTS

1.4.1 The ESCC Component Number

The ESCC Component Number shall be constituted as follows:

Example: 300903401102

Detail Specification Reference: 3009034

Component Type Variant Number: 01 (as required)

• Characteristic code: Capacitance Value (1000pF): 102 (as required)

1.4.1.1 Characteristics and Ratings Codes

Characteristics and ratings to be codified as part of the ESCC Component Number shall be as follows:

(a) Rated Capacitance Value, C_n, expressed by means of the following codes in accordance with ESCC Basic Specification No. 21700. The unit quantity shall be picofarad (pF).

Capacitance Value C _n (pF)	Code
XX 10 ¹	XX1
XX 10 ²	XX2
XX 10 ³	XX3



1.4.2 <u>Component Type Variants and Range of Components</u>

The component type variants and range of components applicable to this specification are as follows:

Variant Number	Style (Note 1)	Capacitance Range (pF) (Note 2)	Tolerance (± %)	Rated Voltage U _R (V)	Termination Finish	Weight Max (g)
01	1812	3900 to 22000	10	1000	No finish	0.3
02	1812	3900 to 22000	20	1000	No finish	0.3
03	1812	1500 to 1800	10	2000	No finish	0.3
04	1812	1500 to 1800	20	2000	No finish	0.3
05	1812	820 to 1000	10	3000	No finish	0.3
06	1812	820 to 1000	20	3000	No finish	0.3
07	1825	27000 to 5600	10	1000	No finish	0.6
08	1825	27000 to 5600	20	1000	No finish	0.6
09	1825	2200 to 6800	10	2000	No finish	0.6
10	1825	2200 to 6800	20	2000	No finish	0.6
11	1825	820 to 3900	10	3000	No finish	0.6
12	1825	820 to 3900	20	3000	No finish	0.6
13	1812	3900 to 22000	10	1000	Sn62 solder dip	0.3
14	1812	3900 to 22000	20	1000	Sn62 solder dip	0.3
15	1812	1500 to 1800	10	2000	Sn62 solder dip	0.3
16	1812	1500 to 1800	20	2000	Sn62 solder dip	0.3
17	1812	820 to 1000	10	3000	Sn62 solder dip	0.3
18	1812	820 to 1000	20	3000	Sn62 solder dip	0.3
19	1825	27000 to 5600	10	1000	Sn62 solder dip	0.6
20	1825	27000 to 5600	20	1000	Sn62 solder dip	0.6
21	1825	2200 to 6800	10	2000	Sn62 solder dip	0.6
22	1825	2200 to 6800	20	2000	Sn62 solder dip	0.6
23	1825	820 to 3900	10	3000	Sn62 solder dip	0.6
24	1825	820 to 3900	20	3000	Sn62 solder dip	0.6

NOTES:

- 1. See Para. 1.6.
- 2. Available capacitance values are as follows:
 - Value series: E12



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1.5 <u>MAXIMUM RATINGS</u>

The maximum ratings shall not be exceeded at any time during use or storage.

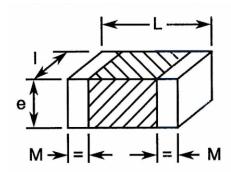
Maximum ratings shall only be exceeded during testing to the extent specified in this specification and when stipulated in Test Methods and Procedures of the ESCC Generic Specification.

Characteristics	Symbols	Maximum Ratings	Units	Remarks
Rated Voltage	U _R	1000, 2000, 3000	V	Note 1
Operating Temperature Range	Тор	-55 to +125	°C	Without derating. T _{amb}
Storage Temperature Range	T _{stg}	-55 to +125	°C	
Soldering Temperature	T _{sol}	+260	°C	Note 2

NOTES:

- 1. As required; See Para. 1.4.2.
- 2. Duration 5 seconds maximum.

1.6 PHYSICAL DIMENSIONS



Symbols		Dimensions (mm)						
	Style	Style 1812		Style 1825		Style 1812		1825
	Variants	01 to 06	Variants	Variants 07 to 12 Variants		13 to 18	Variants	19 to 24
	Min	Max	Min	Max	Min	Max	Min	Max
L	4.2	5	4.2	5	4.2	5.5	4.2	5.5
I	2.8	3.6	5.67	6.67	2.8	4.1	5.67	7.17
е	-	3	-	3.3	-	3.5	-	3.8
М	0.25	0.75	0.25	0.75	0.25	0.75	0.25	0.75

1.7 <u>FUNCTIONAL DIAGRAM</u>



1.8 MATERIALS AND FINISHES

The components shall be terminated with metallised pads. The termination finish shall be as specified in Para. 1.4.2.

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2 REQUIREMENTS

2.1 GENERAL

The complete requirements for procurement of the components specified herein are as stated in this specification and the ESCC Generic Specification. Permitted deviations from the Generic Specification, applicable to this specification only, are listed below.

Permitted deviations from the Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESCC requirement and do not affect the component's reliability, are listed in the appendices attached to this specification.

2.1.1 Deviations from the Generic Specification

2.1.1.1 Deviations from Qualification and Periodic Tests - Chart F4

(a) Steady State Humidity (85/85): not applicable and shall be replaced in Chart F4 Subgroup 1 of the Generic Specification by a Damp Heat Steady State test as follows:

Components mounted in accordance with Para. 8.6 of ESCC No. 3009 shall be subjected to Test Cab of IEC Publication No. 60068-2-78. The following details shall apply:

• Test Conditions:

(a) Temperature: 40 ±2°C

(b) Relative humidity: 93 ±3%

(c) Duration: 56 days

(d) Bias during test: Unless otherwise specified, no bias shall be applied.

Data Points:

Prior to the test, Capacitance shall be measured as specified in Para. 2.4 Intermediate and End-Point Electrical Measurements.

On completion of testing, the components shall be subjected to standard atmospheric conditions for recovery for 6 to 24 hours.

After recovery, the components shall be visually examined. There shall be no evidence of damage. Capacitance, Change in Capacitance, Tangent of Loss Angle and Insulation Resistance shall be measured as specified in Para. 2.4 Intermediate and End-Point Electrical Measurements. Change in Capacitance shall be related to the initial measurements.

2.2 MARKING

The marking shall be in accordance with the requirements of ESCC Basic Specification No. 21700 and as follows.

The information to be marked on the component or its primary package shall be:

- (a) The ESCC qualified components symbol (for ESCC qualified components only).
- (b) The ESCC Component Number (see Para. 1.4.1).
- (c) Traceability information.



2.3 <u>ELECTRICAL MEASUREMENTS AT ROOM, HIGH AND LOW TEMPERATURES</u>

Electrical measurements shall be performed at room, high and low temperatures.

2.3.1 Room Temperature Electrical Measurements

The measurements shall be performed at $T_{amb} = +22 \pm 3^{\circ}C$.

Characteristics	Symbols	Test Method and Conditions	Tolerance	Lir	Units	
		Conditions	(± %)	Min	Max	
Capacitance	CA	ESCC No. 3009				pF
(Note 1)			10	0.9C _n	1.1C _n	
			20	0.8C _n	1.2C _n	
Tangent of Loss Angle	tgδ	ESCC No. 3009	All	-	250 x10 ⁻⁴	-
Insulation	Rı	ESCC No. 3009	All			
Resistance		For C _n ≤ 10000pF		100	-	GΩ
		For C _n > 10000pF		1000	-	GΩ.nF
Voltage Proof	VP	ESCC No. 3009	All			V
		For U _R < 1250V		1.5U _R	-	
		For U _R > 1250V		1.3U _R	-	

NOTES

2.3.2 High and Low Temperatures Electrical Measurements

Characteristics	Symbols	Test Method and Conditions (Note 1)	Lin	nits	Units
		(Note 1)	Min	Max	
Insulation Resistance	Rı	ESCC No. 3009 T _{amb} = +125 ±2°C Note 2			
		For C _n ≤ 10000pF	10	-	GΩ
		For C _n > 10000pF	100	-	GΩ.nF
Temperature Characteristic	TC	ESCC No. 3009 T _{amb} = -55 ±2°C, +20 ±2°C, +125 ±2°C Note 3			%
		For V_T = no voltage applied	-20	+20	
		For V _T = 500V	-50	+30	

NOTES:

- The measurements shall be performed on a sample of 5 components from each manufacturing lot with 0 failures allowed. In the event of any failure a 100% inspection may be performed.
- 2. Guaranteed but not tested during Chart F3 of the Generic Specification; only tested in Temperature Characterisation during Chart F4 of the Generic Specification.
- 3. In the case of a 100% inspection, a 1% total percent defective is allowed.

Capacitance limits may be adjusted to take into account capacitance ageing, as specified in the Generic Specification.



2.4 <u>INTERMEDIATE AND END-POINT ELECTRICAL MEASUREMENTS</u>

Unless otherwise specified, the measurements shall be performed at T_{amb} = +22 ±3°C.

Unless otherwise specified the test methods and test conditions shall be as per the corresponding test defined in Para. 2.3.1 Room Temperature Electrical Measurements.

Test Reference per ESCC Characteristics		Symbols	Limits		Units
No. 3009			Min	Max	
Mounting				<u> </u>	
Final Measurements	Capacitance	C_A	Record	l Values	
	Tangent of Loss Angle	tgδ	-	250 x10 ⁻⁴	-
	Insulation Resistance	Rı	No	te 1	
Rapid Change of Temperature					
Initial Measurements	Capacitance	CA	Note	s 1, 2	
Final Measurements	Capacitance	CA	Note 1		
	Change in Capacitance	ΔC _A /C _A	-10	+10	%
	Tangent of Loss Angle	tgδ	-	500 x10 ⁻⁴	-
Damp Heat Steady State					
Initial Measurements	Capacitance	C_{A}	No	te 1	
Final Measurements	Capacitance	C_A	No	te 1	
	Change in Capacitance	ΔC _A /C _A	-10	+10	%
	Tangent of Loss Angle	tgδ	-	500 x10 ⁻⁴	-
	Insulation Resistance:				
	For C _n ≤ 10000pF	Rı	3	-	GΩ
	For C _n > 10000pF	Rı	30	-	GΩ.nF



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Test Reference per ESCC Characteristics		Symbols	Lir	nits	Units
No. 3009			Min	Max	
Operating Life					
Initial Measurements	Capacitance	CA	Note	s 1, 2	
Intermediate Measurements	Capacitance	CA	No	te 1	
(1000 hours) (Note 3)	Change in Capacitance	$\Delta C_A/C_A$	-15	+15	%
	Insulation Resistance:				
	For C _n ≤ 10000pF	Rı	10	-	GΩ
	For C _n > 10000pF	Rı	100	-	GΩ.nF
Final Measurements	Capacitance	CA	Note 1		
(1000 or 2000 hours) (Note 4)	Change in Capacitance	ΔC _A /C _A	-15	+15	%
	Tangent of Loss Angle	tgδ	-	500 x10 ⁻⁴	-
	Insulation Resistance:				
	For C _n ≤ 10000pF	Rı	10	-	GΩ
	For C _n > 10000pF	Rı	100	-	GΩ.nF
	Voltage Proof	VP	No	te 1	
Temperature Characterisation	Insulation Resistance at T _{amb} = +125 ±2°C	Rı	No	te 5	
	Temperature Characteristic	TC	No	te 5	
Robustness of Terminations					
Final Measurements	Capacitance	CA	No	te 1	

NOTES:

- 1. As specified in Para. 2.3.1 Room Temperature Electrical Measurements.
- 2. Capacitance values recorded during Mounting may be used as initial measurements.
- 3. Intermediate measurements are optional at the Manufacturer's discretion.
- 4. 1000 hours is applicable to Periodic Testing for extension of qualification. 2000 hours is applicable to Qualification Testing, and to Periodic Testing for renewal of qualification after lapse.
- 5. As specified in Para. 2.3.2 High and Low Temperatures Electrical Measurements.

2.5 BURN-IN

The requirements for Burn-in are specified in the ESCC Generic Specification. The following conditions shall also apply:

• After Burn-in, the components shall be removed from the chamber and allowed to cool under normal atmospheric conditions for recovery for 24 hours minimum.



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APPENDIX A AGREED DEVIATIONS FOR AVX LTD (GB)

Items Affected	Description of Deviations
Para. 2.1.1 Deviations from the Generic Specification: Special In-Process Controls - Chart F2	Microsection Inspection: may be performed using AVX inspection document as per PID.